

# P-Channel 150 V (D-S) 175 °C MOSFET

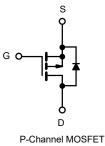
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	- 150			
$R_{DS(on)}(\Omega)$ at $V_{GS}$ = - 10 V	0.065			
$R_{DS(on)}(\Omega)$ at $V_{GS}$ = - 4.5 V	0.070			
I <sub>D</sub> (A)	- 40			
Configuration	Single			

#### FEATURES

- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- Package with Low Thermal Resistance
- 100 % R<sub>g</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC







<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \degree C$ , unless otherwise noted)						
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	- 150	v		
Gate-Source Voltage		V <sub>GS</sub>	± 20	v		
Continuous Drain Current	T <sub>C</sub> = 25 °C	- I <sub>D</sub> -	- 40			
	T <sub>C</sub> = 125 °C		- 25			
Continuous Source Current (Diode Conduction) <sup>a</sup>		۱ <sub>S</sub>	- 25	А		
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	- 55			
Single Pulse Avalanche Current		I <sub>AS</sub>	- 22			
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	103	mJ		
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	PD	75	W		
	T <sub>C</sub> = 125 °C	۳D	37	vv		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C		

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	50	°C/W	
Junction-to-Case (Drain)			1.1	C/W	

#### Notes

- a. Package limited.
- b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.

<b>SPECIFICATIONS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted)								
PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT	
Static	•	•						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$		- 150	-	-	V	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$		-	-3.5		
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> =	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 20 \text{ V}$		-	± 100	nA	
Zero Gate Voltage Drain Current		$V_{GS} = 0 V$	V <sub>DS</sub> = - 100 V	-	-	- 1	μA	
	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS}$ = - 100 V, $T_{J}$ = 125 °C	-	-	- 50		
		$V_{GS} = 0 V$	$V_{DS}$ = - 100 V, $T_{J}$ = 175 °C	-	-	- 250		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{GS} = -10 V$	$V_{DS} \le$ - 5 V	- 30	-	-	А	
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 9 A	-	0.065	-	Ω	
	Para	$V_{GS} = -10 V$	I <sub>D</sub> = - 9 A, T <sub>J</sub> = 125 °C	-	0.088	-		
	R <sub>DS(on)</sub>	$V_{GS} = -10 V$	I <sub>D</sub> = - 9 A, T <sub>J</sub> = 175 °C	-	-	0.113		
		$V_{GS} = -4.5 V$	I <sub>D</sub> = - 7.7 A	-	0.07	-		
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 9.2 A		-	35	-	S	
Dynamic <sup>b</sup>								
Input Capacitance	C <sub>iss</sub>		V <sub>DS</sub> = - 25 V, f = 1 MHz	-	5000	-	pF	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V		-	301	380		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	208	260		
Total Gate Charge <sup>c</sup>	Qg	V <sub>GS</sub> = - 10 V	V <sub>DS</sub> = - 50V, I <sub>D</sub> = - 9.2 A	-	96	144	nC	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>			-	8.4	-		
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>	1		-	23.5	-		
Gate Resistance	Rg	f = 1 MHz		1.5	3.13	4.7	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>				11	17	ns	
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = - 50 V, R <sub>L</sub> = 6.49 $\Omega$ I <sub>D</sub> $\cong$ - 7.7 A, V <sub>GEN</sub> = - 10 V, R <sub>g</sub> = 1.0 $\Omega$		-	11	17		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>			-	78	117		
Fall Time <sup>c</sup>	t <sub>f</sub>			-	15	23		
Source-Drain Diode Ratings and Chara	acteristics <sup>b</sup>							
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 50	A	
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = - 7.7 A, V <sub>GS</sub> = 0 V		-	- 0.8	- 1.5	V	

#### Notes

a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

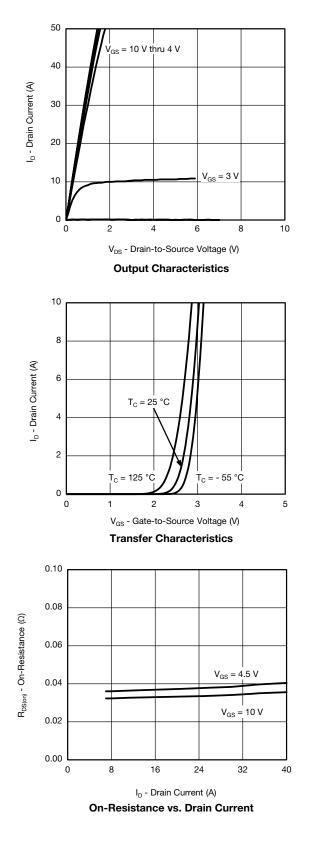
c. Independent of operating temperature.

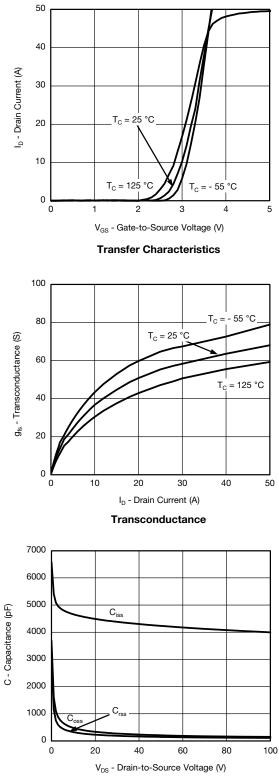
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)

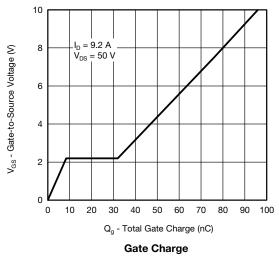


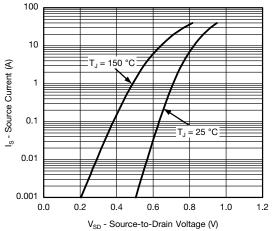


Capacitance

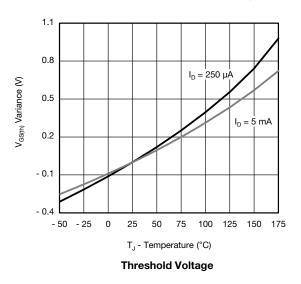


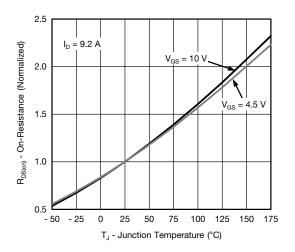
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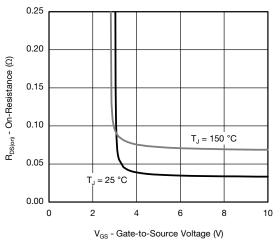


Source Drain Diode Forward Voltage

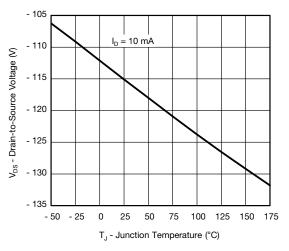




**On-Resistance vs. Junction Temperature** 



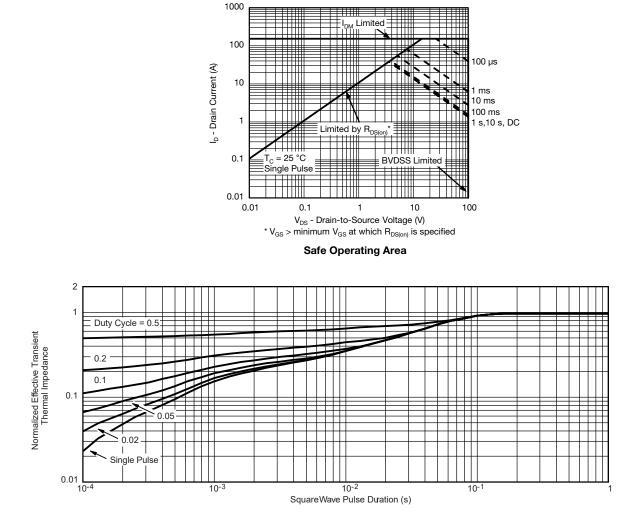
On-Resistance vs. Gate-to-Source Voltage



Drain Source Breakdown vs. Junction Temperature



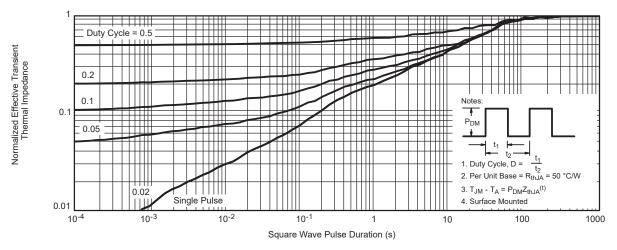
## **THERMAL RATINGS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case



### **THERMAL RATINGS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

#### Note

• The characteristics shown in the two graphs

- Normalized Transient Thermal Impedance Junction to Ambient (25 °C)

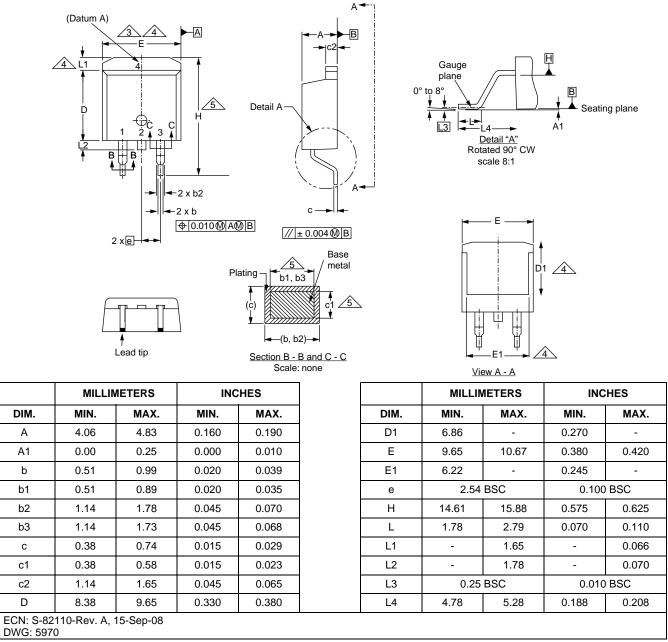
- Normalized Transient Thermal Impedance Junction to Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

# VBL2157N



#### **TO-263AB**



#### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



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